## Notice of References Cited Application/Control No. 10/757,840 Examiner | Art Unit Cong-Lac Huynh Applicant(s)/Patent Under Reexamination LUE, VINCENT WEN-JENG Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,513,315 A	04-1996	Tierney et al.	714/37
*	В	US-2007/0009179 A1	01-2007	Easwar, Venkat	382/276
*	C	US-2007/0051685 A1	03-2007	Wittmer et al.	210/695
*	D	US-2007/0185959 A1	08-2007	Huck et al.	709/204
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R	•				
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Ko et al., A Structured Documents Retrieval Method Supporting Attribute-based Structure Information, ACM 2002, pages 668-674.
	V	Fuller et al., Structured Answers for a Large Structured Document Collection, ACM 1993, pages 204-213.
	v	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.